

Search Notes

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Examiner

Jason M. Han

Applicant(s)/Patent under
Reexamination

ARIK ET AL.

Art Unit

2875

SEARCHED

Class	Subclass	Date	Examiner
362	555, 800	2/18/2005	JMH
362	294	2/18/2005	JMH
362	373	2/18/2005	JMH
310	311	2/18/2005	JMH
310	322	2/18/2005	JMH
310	325	2/18/2005	JMH
310	328	2/18/2005	JMH
310	343	2/18/2005	JMH
310	346	2/18/2005	JMH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search Update	2/18/2005	JMH
P.E. John Ward	2/18/2005	JMH